- B-Port Outputs Have Equivalent $25-\Omega$ Series Resistors, So No External Resistors Are Required
- State-of-the-Art EPIC-IIB ${ }^{\text {TM }}$ BiCMOS Design Significantly Reduces Power Dissipation
- Latch-Up Performance Exceeds 500 mA Per JEDEC Standard JESD-17
- ESD Protection Exceeds 2000 V Per MIL-STD-833, Method 3015; Exceeds 200 V Using Machine Model ( $\mathrm{C}=200 \mathrm{pF}, \mathrm{R}=0$ )
- Typical $\mathrm{V}_{\text {OLP }}$ (Output Ground Bounce) $<1 \mathrm{~V}$ at $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$
- High-Impedance State During Power Up and Power Down
- Package Options Include Plastic Small-Outline (DW), Shrink Small-Outline (DB), and Thin Shrink Small-Outline (PW) Packages, Ceramic Chip Carriers (FK), Plastic (N) and Ceramic (J) DIPs, and Ceramic Flat (W) Package


## description

These octal transceivers and line drivers are designed for asynchronous communication between data buses. The devices transmit data from the $A$ bus to the $B$ bus or from the $B$ bus to the A bus, depending on the logic level at the direction-control (DIR) input. The output-enable ( $\overline{\mathrm{OE})}$ input can be used to disable the device so the buses are effectively isolated.
The B-port outputs, which are designed to sink up to 12 mA , include equivalent $25-\Omega$ series resistors to reduce overshoot and undershoot.

When $\mathrm{V}_{\mathrm{CC}}$ is between 0 and 2.1 V , the device is in the high-impedance state during power up or power down. However, to ensure the high-impedance state above 2.1 V , $\overline{\mathrm{OE}}$ should be tied to $\mathrm{V}_{\mathrm{CC}}$ through a pullup resistor; the minimum value of the resistor is determined by the current-sinking/current-sourcing capability of the driver.

The SN54ABT2245 is characterized for operation over the full military temperature range of $-55^{\circ} \mathrm{C}$ to $125^{\circ} \mathrm{C}$. The SN74ABT2245 is characterized for operation from $-40^{\circ} \mathrm{C}$ to $85^{\circ} \mathrm{C}$.

FUNCTION TABLE

| INPUTS |  | OPERATION |
| :---: | :---: | :---: |
| $\overline{\mathrm{OE}}$ | DIR |  |
| L | L | B data to $A$ bus |
| L | H | A data to B bus |
| H | X | Isolation |

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## WITH 3-STATE OUTPUTS

SCBS234D - SEPTEMBER 1992 - REVISED MAY 1997
logic symbol $\dagger$

$\dagger$ This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.
logic diagram (positive logic)


To Seven Other Channels

## schematic of A-port outputs



## schematic of B-port outputs



All resistor values shown are nominal.

## absolute maximum ratings over operating free-air temperature range (unless otherwise noted) $\dagger$

| Supply voltage range, $\mathrm{V}_{\mathrm{CC}}$ Input voltage range, $\mathrm{V}_{1}$ (except I/O ports) (see Note 1) | -0.5 V to 7 V |
| :---: | :---: |
|  | -0.5 V to 7 V |
|  |  |
| Current into any output in the low state, Io: SN54ABT2245 (except B port) | 96 mA |
| SN74ABT2245 (except B port) | 128 mA |
| B port | 30 m |
| Input clamp current, $\mathrm{I}_{\mathrm{K}}\left(\mathrm{V}_{1}<0\right)$ |  |
| Output clamp current, $\mathrm{I}_{\mathrm{OK}}\left(\mathrm{V}_{\mathrm{O}}<0\right)$ |  |
| Package thermal impedance, $\theta_{\mathrm{JA}}$ (see Note 2): DB package | $115^{\circ} \mathrm{C} / \mathrm{W}$ |
| DW package | $97^{\circ} \mathrm{C} / \mathrm{W}$ |
| N package | $67^{\circ} \mathrm{C} / \mathrm{W}$ |
| PW package | $128^{\circ} \mathrm{C} / \mathrm{W}$ |
| Storage temperature range, $\mathrm{T}_{\text {stg }}$ | $65^{\circ} \mathrm{C}$ to $150^{\circ} \mathrm{C}$ |

$\dagger$ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
2. The package thermal impedance is calculated in accordance with EIA/JEDEC Std JESD51, except for through-hole packages, which use a trace length of zero.

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recommended operating conditions (see Note 3)


NOTE 3: Unused pins (input or I/O) must be held high or low to prevent them from floating.

# SN54ABT2245, SN74ABT2245 OCTAL TRANSCEIVERS AND LINE/MOS DRIVERS WITH 3-STATE OUTPUTS 

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER |  | TEST CONDITIONS |  | $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ |  |  | SN54ABT2245 |  | SN74ABT2245 |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | MIN | TYPt | MAX | MIN | MAX | MIN | MAX |  |
| $\mathrm{V}_{\mathrm{IK}}$ |  |  |  | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}$, | $\mathrm{I}=-18 \mathrm{~mA}$ |  |  | -1.2 |  | -1.2 |  | -1.2 | V |
| VOH | B port | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}$, | $\mathrm{IOH}=-1 \mathrm{~mA}$ | 3.35 |  |  | 3.3 |  | 3.35 |  | V |
|  |  | $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}$, | $\mathrm{IOH}=-1 \mathrm{~mA}$ | 3.85 |  |  | 3.8 |  | 3.85 |  |  |
|  |  | $\mathrm{V}_{C C}=4.5 \mathrm{~V}$ | $\mathrm{IOH}=-3 \mathrm{~mA}$ |  |  |  | 3 |  | 3.1 |  |  |
|  |  |  | $1 \mathrm{OH}=-12 \mathrm{~mA}$ | 2.6 |  |  |  |  | 2.6 |  |  |
|  | A port | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}, \quad \mathrm{IOH}=-3 \mathrm{~mA}$ |  | 2.5 |  |  | 2.5 |  | 2.5 |  |  |
|  |  | $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}$, | $\mathrm{IOH}=-3 \mathrm{~mA}$ | 3 |  |  | 3 |  | 3 |  |  |
|  |  | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}$ | $\mathrm{IOH}=-24 \mathrm{~mA}$ | 2 |  |  | 2 |  |  |  |  |
|  |  |  | $\mathrm{IOH}=-32 \mathrm{~mA}$ | $2^{*}$ |  |  |  |  | 2 |  |  |
| $\mathrm{V}_{\text {OL }}$ | B port | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}$ | $\mathrm{I} \mathrm{OL}=8 \mathrm{~mA}$ |  |  | 0.65 |  | 0.8 |  | 0.65 | V |
|  |  |  | $\mathrm{l} \mathrm{OL}=12 \mathrm{~mA}$ |  |  | 0.8 |  |  |  | 0.8 |  |
|  | A port |  | $\mathrm{IOL}=48 \mathrm{~mA}$ |  |  | 0.55 |  | 0.55 |  |  |  |
|  |  |  | $\mathrm{IOL}=64 \mathrm{~mA}$ |  |  | 0.55* |  |  |  | 0.55 |  |
| $\mathrm{V}_{\text {hys }}$ |  |  |  |  | 100 |  |  |  |  |  | mV |
| 1 | Control inputs | $\mathrm{V}_{\mathrm{CC}}=0$ to $5.5 \mathrm{~V}, \mathrm{~V}_{\mathrm{I}}=\mathrm{V}_{\mathrm{CC}}$ or GND |  |  |  | $\pm 1$ |  | $\pm 1$ |  | $\pm 1$ | $\mu \mathrm{A}$ |
|  | A or B ports | $\begin{aligned} & \begin{array}{l} \mathrm{V}_{\mathrm{CC}}=2.1 \mathrm{~V} \text { to } 5.5 \mathrm{~V}, \\ \mathrm{~V}_{\mathrm{I}}=\mathrm{V}_{\mathrm{CC}} \text { or } \mathrm{GND} \end{array} \end{aligned}$ |  |  |  | $\pm 20$ |  | $\pm 20$ |  | $\pm 20$ |  |
| $\mathrm{l}^{\text {OZH }}{ }^{\ddagger}$ |  | $\begin{aligned} & \hline \mathrm{V}_{\mathrm{CC}}=2.1 \mathrm{~V} \text { to } 5.5 \mathrm{~V}, \\ & \mathrm{~V}_{\mathrm{O}}=2.7 \mathrm{~V}, \overline{\mathrm{OE}} \geq 2 \mathrm{~V} \end{aligned}$ |  |  |  | 10 |  | 10 |  | 10 | $\mu \mathrm{A}$ |
| IOZL ${ }^{\ddagger}$ |  | $\begin{aligned} & \mathrm{V}_{\mathrm{CC}}=2.1 \mathrm{~V} \text { to } 5.5 \mathrm{~V}, \\ & \mathrm{~V}_{\mathrm{O}}=0.5 \mathrm{~V}, \overline{\mathrm{OE}} \geq 2 \mathrm{~V} \end{aligned}$ |  |  |  | -10 |  | -10 |  | -10 | $\mu \mathrm{A}$ |
| Iozpu§ |  | $\begin{aligned} & \mathrm{V}_{\mathrm{CC}}=0 \text { to } 2.1 \mathrm{~V}, \\ & \mathrm{~V}_{\mathrm{O}}=0.5 \mathrm{~V} \text { to } 2.7 \mathrm{~V}, \overline{\mathrm{OE}}=\mathrm{x} \end{aligned}$ |  |  |  | $\pm 50$ |  | $\pm 50$ |  | $\pm 50$ | $\mu \mathrm{A}$ |
| IOZPD§ |  | $\begin{aligned} & \mathrm{V}_{\mathrm{CC}}=2.1 \mathrm{~V} \text { to } 0, \\ & \mathrm{~V}_{\mathrm{O}}=0.5 \mathrm{~V} \text { to } 2.7 \mathrm{~V}, \overline{\mathrm{OE}}=\mathrm{x} \end{aligned}$ |  |  |  | $\pm 50$ |  | $\pm 50$ |  | $\pm 50$ | $\mu \mathrm{A}$ |
| $l_{\text {off }}$ |  | $\mathrm{V}_{\mathrm{CC}}=0$.$\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{V}_{1}$ or $\mathrm{V}_{\mathrm{O}} \leq 4.5 \mathrm{~V}$ |  |  | $\pm 100$ |  |  |  | $\pm 100$ | $\mu \mathrm{A}$ |
| ${ }^{\text {ICEX }}$ | Outputs high |  | $\mathrm{V}_{\mathrm{O}}=5.5 \mathrm{~V}$ | 50 |  |  | 50 |  |  | 50 | $\mu \mathrm{A}$ |
| $10 \\|$ | B port | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{V}_{\mathrm{O}}=2.5 \mathrm{~V}$ | -25 |  | -100 | -25 | -100 | -25 | -100 | mA |
|  | A port |  |  | -50 | -100 | -180 | -50 | -180 | -50 | -180 |  |
| ICC | A or B ports | $\begin{aligned} & \mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}, \\ & \mathrm{l}^{\mathrm{O}}=0, \\ & \mathrm{~V}_{\mathrm{I}}=\mathrm{V}_{\mathrm{CC}} \text { or } \mathrm{GND} \end{aligned}$ | Outputs high |  | 1 | 250 |  | 250 |  | 250 | $\mu \mathrm{A}$ |
|  |  |  | Outputs low |  | 24 | 32 |  | 32 |  | 32 | mA |
|  |  |  | Outputs disabled |  | 0.5 | 250 |  | 250 |  | 250 | $\mu \mathrm{A}$ |
| ${ }^{\prime} \mathrm{CCC}^{\#}$ | Data inputs | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V},$ <br> One input at 3.4 V , Other inputs at $\mathrm{V}_{\mathrm{CC}}$ or GND | Outputs enabled |  |  | 1.5 |  | 1.5 |  | 1.5 | mA |
|  |  |  | Outputs disabled |  |  | 0.05 |  | 0.05 |  | 0.05 |  |
|  | Control inputs | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, One input at 3.4 V , Other inputs at $\mathrm{V}_{\mathrm{CC}}$ or GND |  |  |  | 1.5 |  | 1.5 |  | 1.5 |  |
| $\mathrm{C}_{i}$ |  | $\mathrm{V}_{\mathrm{I}}=2.5 \mathrm{~V}$ or 0.5 V |  | 3 |  |  |  |  |  |  | pF |
| $\mathrm{C}_{\text {io }}$ |  | $\mathrm{V}_{\mathrm{O}}=2.5 \mathrm{~V}$ or 0.5 V |  |  |  |  |  |  |  |  | pF |

[^0]
## WITH 3-STATE OUTPUTS

SCBS234D - SEPTEMBER 1992 - REVISED MAY 1997
switching characteristics over recommended ranges of supply voltage and operating free-air temperature, $\mathrm{C}_{\mathrm{L}}=50 \mathrm{pF}$ (unless otherwise noted) (see Figure 1)

| PARAMETER | FROM (INPUT) | $\begin{gathered} \text { TO } \\ \text { (OUTPUT) } \end{gathered}$ | $\begin{aligned} & \mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}, \\ & \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C} \end{aligned}$ |  |  | SN54ABT2245 |  | SN74ABT2245 |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | MIN | TYP | MAX | MIN | MAX | MIN | MAX |  |
| tPLH | A | B | 1 | 2.5 | 3.4 | 1 | 4 | 1 | 3.8 | ns |
| tPHL |  |  | 1 | 3.2 | 4.2 | 1 | 4.6 | 1 | 4.5 |  |
| tPLH | B | A | 1 | 2.2 | 3.2 | 1 | 3.8 | 1 | 3.6 | ns |
| tPHL |  |  | 1 | 2.7 | 3.6 | 1 | 4.2 | 1 | 4 |  |
| tPZH | $\overline{\mathrm{OE}}$ | A | 1 | 3.3 | 4.6 | 1 | 5.6 | 1 | 5.5 | ns |
| tPZL |  |  | 1 | 3.2 | 4.7 | 1 | 6 | 1 | 5.7 |  |
| tPHZ | $\overline{\mathrm{OE}}$ | A | 2 | 4 | 5.1 | 2 | 5.7 | 2 | 5.6 | ns |
| tPLZ |  |  | 1 | 2.9 | 4 | 1 | 4.6 | 1 | 4.5 |  |
| tPZH | $\overline{\mathrm{OE}}$ | B | 1.5 | 3.6 | 4.9 | 1.5 | 6.3 | 1.5 | 6.1 | ns |
| tPZL |  |  | 1.5 | 3.9 | 5.3 | 1.5 | 6.6 | 1.5 | 6.3 |  |
| tPHZ | $\overline{\mathrm{OE}}$ | B | 1.5 | 3.6 | 4.7 | 1.5 | 5.5 | 1.5 | 5.3 | ns |
| tPLZ |  |  | 1.5 | 3.3 | 4.4 | 1.5 | 4.9 | 1.5 | 4.8 |  |

## PARAMETER MEASUREMENT INFORMATION



| TEST | S1 |
| :---: | :---: |
| $\mathbf{t}_{\text {PLH }} / \mathbf{t}^{\text {PHL }}$ | Open |
| $\mathbf{t}_{\text {PLZ }} / \mathbf{t} \mathbf{P Z L}$ | 7 V |
| $\mathbf{t}_{\text {PHZ }} / \mathbf{t} \mathbf{P Z H}$ | Open |



VOLTAGE WAVEFORMS SETUP AND HOLD TIMES


VOLTAGE WAVEFORMS PROPAGATION DELAY TIMES INVERTING AND NONINVERTING OUTPUTS

NOTES: A. $C_{L}$ includes probe and jig capacitance.
B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
C. All input pulses are supplied by generators having the following characteristics: $\mathrm{PRR} \leq 10 \mathrm{MHz}, \mathrm{Z}_{\mathrm{O}}=50 \Omega, \mathrm{t}_{\mathrm{r}} \leq 2.5 \mathrm{~ns}, \mathrm{t}_{\mathrm{f}} \leq 2.5 \mathrm{~ns}$.
D. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms

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[^0]:    * On products compliant to MIL-PRF-38535, this parameter does not apply.
    $\dagger$ All typical values are at $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}$.
    $\ddagger$ The parameters $\mathrm{I}_{\mathrm{OZH}}$ and $\mathrm{l}_{\mathrm{OZL}}$ include the input leakage current.
    § This parameter is characterized but not production tested.
    I Not more than one output should be tested at a time, and the duration of the test should not exceed one second.
    \# This is the increase in supply current for each input that is at the specified TTL voltage level rather than $\mathrm{V}_{\mathrm{CC}}$ or GND.

